

TOSHIBA

TOSHIBA HOKUTO ELECTRONICS CORPORATION
MAGNETRON ENGINEERING GROUP, MAGNETRON DIVISION
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Mr. R. Kanemitsu
Deputy General Manager
Research & Development Department
Crystal Electric Co., Ltd.
3-22-5, Higashinakamoto,
Higashinari-ku,
Osaka 537-0021, Japan

Report No. : 04-123
Issued date : October 11, 2004

Re : EMC test result in your model MFMK-7TP microwave oven with Toshiba magnetron 2M216H(IF)-Z

Dear R. Kanemitsu,

We are enclosing the above mentioned test results based on CISPR11:1990+A2:1996 in our measuring facility.

Please feel free to contact us, if you have any question or request.

Sincerely yours,


Akira Yamada
Manager
Magnetron Engineering Group
Magnetron Division

YM/HR

CC :

This report is made only to examine whether the magnetron operates properly as incorporated into the microwave oven that you provided to us, and based upon examinations under limited conditions.

This report is not to make any type of warranty on the quality, performance nor safety of any microwave oven manufactured by you. Therefore, you should carry out thorough approval tests before and during manufacturing microwave ovens.

In case any claim or problem arises from any defect due to this report, our total liability shall be limited to replacement of the magnetrons in question or refunding the prices allocable to such magnetrons.

EMI test report

1. Test laboratory

Toshiba Hokuto Electronics Corporation
Magnetron Engineering Group, Magnetron Division
Laboratory for EMI measurements
1975-Banchi, 23-Chome, Minami 5-Jodori, Asahikawa 078-8335, Japan
Tel : +81-166-31-4728 Fax : +81-166-31-4739

2. Specification of EUT

Manufacturer	:	Crystal Electric Co., Ltd.
Equipment	:	Microwave Oven
Model No.	:	MFMK-7TP
Line voltage	:	120V/60Hz
Output power	:	800W
Magnetron	:	TOSHIBA 2M216H(IF)-Z

3. Test specification

Test specification	:	CISPR11:1990+A2:1996
Equipment classification	:	Group 2, Class B

4. Test result

4.1 Mains terminal disturbance voltage (Frequency range : 0.15MHz to 30MHz)

Test specification	:	CISPR11:1990+A2:1996
Limit	:	Table 2b, Group 2, Class B (Clause 5.1.2.1)
Frequency range	:	0.15MHz to 30MHz
Result	:	Pass
Tested date	:	October 11, 2004
Test engineer	:	S.Hirotani
Data of test results	:	Refer to Page 4

4.2 Electromagnetic radiation disturbance test (Frequency range : 30MHz to 1000MHz)

Test specification	:	CISPR11:1990+A2:1996
Limit	:	Table 4, Group 2, Class B (Clause 5.2.2)
Frequency range	:	30MHz to 1000MHz
Result	:	(Pass) See also the note ;
Tested date	:	October 11, 2004
Test engineer	:	S.Hirotani
Data of test results	:	Refer to Page 5

Note ; This test result is a reference data.

Although CISPR11:1990+A2:1996 Table 4 regulations require measurements on the open site at measurement distance 10m, we measured in the anechoic chamber at measurement distance 3m.

4.3 Electromagnetic radiation disturbance power test (Frequency range : 1GHz to 18GHz)

Test specification	:	CISPR11:1990+A2:1996
Limit	:	57dBpW ; 11.7GHz to 12.7GHz, Group 2, Class B (Clause 5.2.3)
Frequency range	:	1GHz to 18GHz
Result	:	Pass
Tested date	:	October 11, 2004
Test engineer	:	S.Hirotani
Data of test results	:	Refer to Page 6

5. Measuring instruments

Test item	Instruments	Model No. (Serial No.)	Manufacturer	Calibration date (interval)
Mains terminal disturbance voltage test (0.15MHz to 30MHz)	EMI test receiver	ESHS30 (828144/044)	Rohde & Schwarz	March 2004 (Annually)
	LISN	KNW-242 (8-607-6)	Kyoritsu Electrical Works	March 2004 (Annually)
	Coaxial cable	3D-2W	Fujikura	March 2004 (Annually)
Electromagnetic radiation disturbance test (30MHz to 1000MHz)	EMI test receiver	ESVS30 (827957/010)	Rohde & Schwarz	March 2004 (Annually)
	Bilog antenna	CBL6111 (1350)	Chase	
	Coaxial cable	SUCOFLEX100-SF104 (109587/4)		March 2004 (Annually)
Electromagnetic radiation disturbance power test (1GHz to 18GHz)	Spectrum analyzer	8592L (3624A00578)	Hewlett Packard	March 2004 (Annually)
	Horn antenna	5C401A (B176126)	SPC Electronics	
	Pre-amplifier	8449B (3008A01826)	Agilent	March 2004 (Annually)
	Coaxial cable	SUCOFLEX100-SF104 (134223/4)	Suhner	March 2004 (Annually)
	Coaxial cable	SUCOFLEX100-SF104 (144786/4)	Suhner	March 2004 (Annually)

Mains terminal disturbance voltage test (Frequency range : 0.15MHz to 30MHz)

Manufacturer	: Crystal Electric Co., Ltd.	Tested date	: October 11, 2004
Equipment	: Microwave Oven	Temperature, Humidity	: 25°C, 50%
Model No.	: MFMK-7TP	Test site	: Shielded room
Test specification	: CISPR11:1990+A2:1996	Result	: Pass
Equipment classification	: Group 2, Class B	Test engineer	: S.Hirotani
Frequency range	: Table 2b (Clause 5.1.2.1)		
Load condition	: 250ml water (Clause 6.5.4)		
Line voltage	: 120V/60Hz		
Operation mode	: Cooking / 800W		
Magnetron	: TOSHIBA 2M216H(IF)-Z		

CISPR 11 Table 2b : Mains terminal disturbance voltage test

Detector type : Quasi-Peak and Average, IF Bandwidth : 10kHz

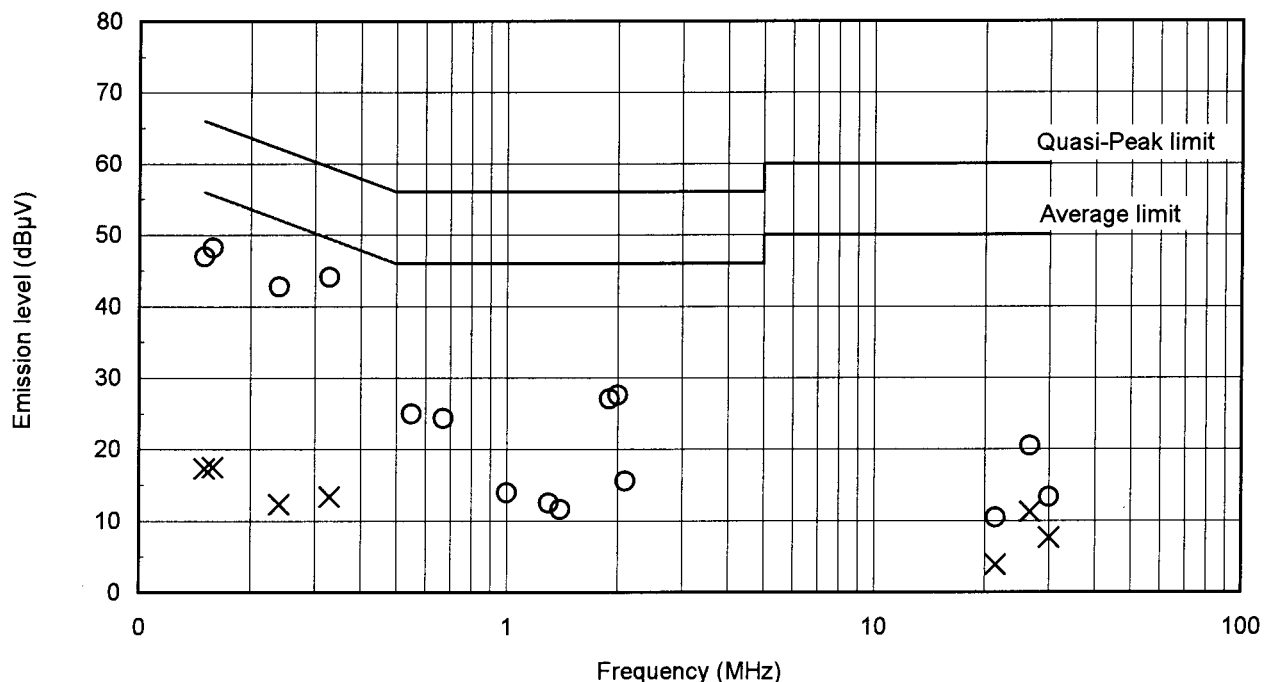
QP : Quasi-Peak, AV : Average

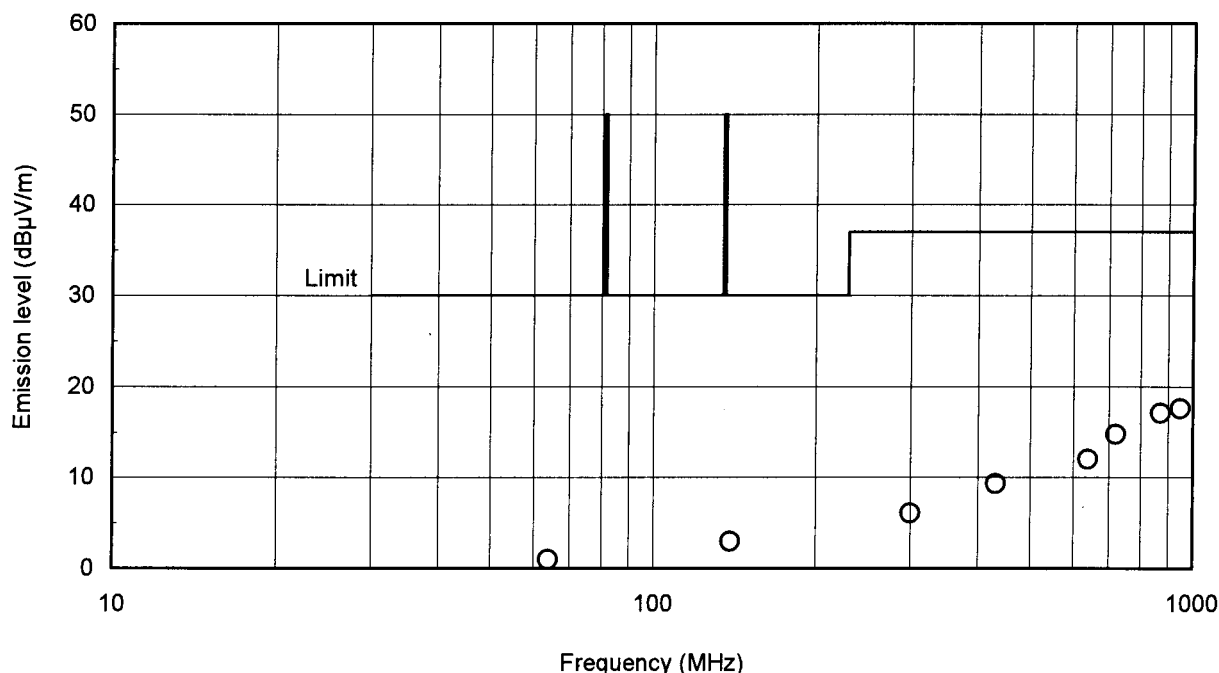
No.	Frequency (MHz)	Reading (dBμV)		LISN factor (dB)	Cable loss (dB)	Atten. (dB)	Result (dBμV)		Limit (dBμV)		Margin (dB)	
		QP	AV				QP	AV	QP	AV	QP	AV
1	0.150	46.7	17.1	0.1	0.1	0.0	46.9	17.3	66.0	56.0	19.1	38.7
2	0.158	48.0	17.3	0.1	0.1	0.0	48.2	17.5	65.8	55.8	17.5	38.2
3	0.240	42.5	12.1	0.1	0.1	0.0	42.7	12.3	63.4	53.4	20.7	41.1
4	0.328	43.9	13.2	0.1	0.1	0.0	44.1	13.4	60.9	50.9	16.8	37.5
5	0.550	24.8	-	0.1	0.1	0.0	25.0	-	56.0	-	31.0	-
6	0.670	24.1	-	0.1	0.1	0.0	24.3	-	56.0	-	31.7	-
7	1.000	13.7	-	0.1	0.1	0.0	13.9	-	56.0	-	42.1	-
8	1.303	12.2	-	0.1	0.1	0.0	12.4	-	56.0	-	43.6	-
9	1.400	11.3	-	0.1	0.1	0.0	11.5	-	56.0	-	44.5	-
10	1.898	26.8	-	0.1	0.1	0.0	27.0	-	56.0	-	29.0	-
11	2.000	27.3	-	0.1	0.2	0.0	27.6	-	56.0	-	28.4	-
12	2.098	15.2	-	0.1	0.2	0.0	15.5	-	56.0	-	40.5	-
13	21.464	8.7	2.2	0.6	1.1	0.0	10.4	3.9	60.0	50.0	49.6	46.1
14	26.562	18.5	9.2	0.7	1.3	0.0	20.5	11.2	60.0	50.0	39.5	38.8
15	30.000	11.0	5.4	0.8	1.5	0.0	13.2	7.6	60.0	50.0	46.8	42.4

Result(dBμV) = Reading(dBμV) + LISN factor(dB) + Cable loss(dB) + Atten.(dB)

CISPR 11 Table 2b : Mains terminal disturbance voltage test

○ : Quasi-Peak, × : Average





Manufacturer	: Crystal Electric Co., Ltd.	Tested date	: October 11, 2004
Equipment	: Microwave Oven	Temperature, Humidity	: 26°C, 69%
Model No.	: MFMK-7TP	Test site	: Anechoic chamber
Test specification	: CISPR11:1990+A2:1996	Measurement distance	: 3m
Equipment classification	: Group 2, Class B	Result	: Pass
Frequency range	: 1GHz to 18GHz (Clause 5.2.3)	Test engineer	: S.Hirotani
Load condition	: 250ml water (Clause 6.5.4)		
Line voltage	: 120V/60Hz		
Operation mode	: Cooking / 800W		
Magnetron	: TOSHIBA 2M216H(IF)-Z		

Detector type : Peak, RBW : 100kHz, VBW : 300kHz H : Horizontal, V : Vertical

[illegible]

CISPR 11 1GHz to 18GHz : Electromagnetic radiation disturbance power test

A graph showing Emission level (dBpW) on the Y-axis versus Frequency (GHz) on the X-axis. The Y-axis ranges from 40 to 70 dBpW, and the X-axis ranges from 0.00 to 19.60 GHz. A horizontal line at approximately 57 dBpW is labeled "Limit". A data point is plotted at 12.25 GHz and 49 dBpW, marked with an 'X' and an open circle.

Frequency (GHz)	Emission level (dBpW)	Marker
12.25	49	X and open circle